

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/724,666	<b>Applicant(s)/Patent under Reexamination</b> SUH ET AL.
	<b>Examiner</b> Erin M. File	<b>Art Unit</b> 2611

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST US PAT, USPPGPUB, EPO, JPO DERWENT, IBM (text search only— see search history printout)	1/2/2007	EMF
PALM INVENTORSHIP	1/2/2007	EMF
PLUS Search	1/3/2007	EMF